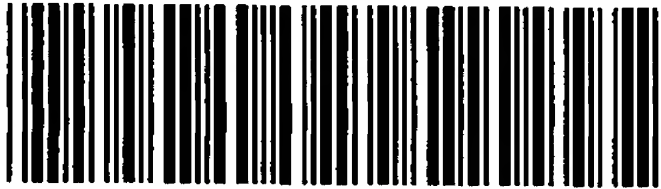


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/628,058	LEE ET AL.	
	Examiner	Art Unit	
	Huyen X. Vo	2626	

SEARCHED			
Class	Subclass	Date	Examiner
704	220; 207; 216; 217	8/13/2007	HV

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Update EAST search included	8/13/2007	HV